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<b>TEST REPORT</b> ETSI EN 301 489-1 V2.1.1 (2017-02)& ETSI EN 301 489-17 V3.1.1 (2017-02)							
Report Reference No.	CTL1808275021-WE						
Compiled by: ( position+printed name+signature) Tested by: ( position+printed name+signature)	Nice Nong Nice Nong						
Approved by: ( position+printed name+signature)	Ivan Xie (Manager)						
Product Name	ShotKam Action Camera						
Model/Type reference	Shotgun ShotKam						
List Model(s)	N/A						
Trade Mark	ShotKam						
Applicant's name	ShotKam LLC						
Address of applicant	2820 NW 45th street, Boca Raton, FL 33434 USA						
Test Firm	Shenzhen CTL Testing Technology Co., Ltd.						
Address of Test Firm	Floor 1-A, Baisha Technology Park, No.3011, Shahexi Road, Nanshan District, Shenzhen, China 518055						
Test specification	Sector Sector						
Standard	ETSI EN 301 489-1 V2.1.1 (2017-02) ETSI EN 301 489-17 V3.1.1 (2017-02)						
TRF Originator	Shenzhen CTL Testing Technology Co., Ltd.						
Master TRF:	Dated 2011-01						
Date of Receipt	Aug. 27, 2018						
Date of Test Date:	Aug. 28, 2018–Sep. 04, 2018						
Data of Issue	Sep. 05, 2018						
Result	Pass						
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# **TEST REPORT**

Test Report No. :	CTL1808275021-WE	Sep. 05, 2018	
		Date of issue	
Equipment under Test :	ShotKam Action Camer	а	
Model /Type :	Shotgun ShotKam		
Listed Models :	N/A		
Applicant :	ShotKam LLC		
Address :	2820 NW 45th street, Be	oca Raton, FL 33434 USA	
Manufacturer :	ShotKam LLC	-14	
Address :	936 Clint Moore Road, I	Boca Raton, FL33487, USA	
Test result	CTL	Pass *	

\* In the configuration tested, the EUT complied with the standards specified page 5. The test report merely corresponds to the test sample. It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

### \*\* Modified History \*\*

Revision	Description	Issued Data	Report No.	Remark
Version 1.0	Initial Test Report Release	2018-09-05	CTL1808275021-WE	Tracy Qi



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### 1 TEST SUMMARY

### 1.1 Test Standards

The tests were performed according to following standards:

ETSI EN 301 489-1 V2.1.1 (2017-02) —Electro Magnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU and the essential requirements of article 6 of Directive 2014/30/EU

**ETSI EN 301 489-17 V3.1.1 (2017-02)** —ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part 17: Specific conditions for Broadband Data Transmission Systems; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU

### **1.2 Test Description**

ETSI EN 301 489-1/ Requirements					
Conducted Emission (AC Mains)	ETSI EN301 489-1 V2.1.1 Clause 7.1	PASS			
Radiated Emission	ETSI EN301 489-1 V2.1.1 Clause 7.1	PASS			
Conducted Emission( Telecommunication Ports)	ETSI EN301 489-1 V2.1.1 Clause 7.1	N/A			
Harmonic Current Emissions	ETSI EN301 489-1 V2.1.1 Clause 7.1	N/A			
Voltage Fluctuations and Flicker	ETSI EN301 489-1 V2.1.1 Clause 7.1	N/A			
Electrostatic Discharge	ETSI EN301 489-1 V2.1.1 Clause 7.2	PASS			
RF Electromagnetic Field	ETSI EN301 489-1 V2.1.1 Clause 7.2	PASS			
Surges	ETSI EN301 489-1 V2.1.1 Clause 7.2	N/A			
Fast Transients Common Mode	ETSI EN301 489-1 V2.1.1 Clause 7.2	N/A			
RF Common Mode 0,15 MHz to 80 MHz	ETSI EN301 489-1 V2.1.1 Clause 7.2	N/A			
Transients and Surges	ETSI EN301 489-1 V2.1.1 Clause 7.2	N/A			
Voltage Dips and Interruptions	ETSI EN301 489-1 V2.1.1 Clause 7.2	N/A			
Testing Techno					

### 1.3 Test Facility

#### 1.3.1 Address of the test laboratory

Shenzhen CTL Testing Technology Co., Ltd.

Floor 1-A, Baisha Technology Park, No. 3011, Shahexi Road, Nanshan, Shenzhen 518055 China

There is one 3m semi-anechoic chamber and two line conducted labs for final test. The Test Sites meet the requirements in documents ANSI C63.4 and CISPR 32/EN 55032 requirements.

#### 1.3.2 Laboratory accreditation

The test facility is recognized, certified, or accredited by the following organizations:

#### IC Registration No.: 9618B

The 3m alternate test site of Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered by Certification and Engineer Bureau of Industry Canada for the performance of with Registration No.: 9618B on November 13, 2013.

#### FCC-Registration No.: 399832

Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 399832, December 08, 2017.

### 1.4 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report according to CISPR 16 - 4

"Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements" and is documented in the Shenzhen CTL Testing Technology Co., Ltd. quality system according to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result

in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Test	Range Measurement Uncertainty		Notes
Radiated Emission	30~1000MHz	10 ±4.10dB	(1)
Radiated Emission	1~12.75GHz	±4.32dB	(1)
Conducted Emission	0.15~30MHz	±3.22dB	(1)

Hereafter the best measurement capability for CTL laboratory is reported:

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Harmonic Current Emission

The measurement uncertainty is evaluated as  $\pm$  1.2 %.

Voltage Fluctuations and Flicker

The measurement uncertainty is evaluated as  $\pm$  1.5 %.

#### Electrostatic Discharge

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in ESD testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant ESD standards. The immunity test signal from the ESD system meet the required specifications in IEC 61000-4-2 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.63% and 2.76%.

#### RF Electromagnetic Field

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in RS testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant RS standards. The immunity test signal from the RS system meet the required specifications in IEC 61000-4-3 through the calibration for the uniform field strength and monitoring for the test level with the uncertainty evaluation report for the electrical filed strength as being 2.72 dB.

#### Fast Transients Common Mode

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in EFT/Burst testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant EFT/Burst standards. The immunity test signal from the EFT/Burst system meet the required specifications in IEC 61000-4-4 through the calibration report with the calibrated uncertainty for the waveform of voltage. Frequency and timing as being 1.63% and 2.76%.

#### Surges

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in Surge testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant Surge standards. The immunity test signal from the Surge system meet the required specifications in IEC 61000-4-5 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.63% and 2.76%.

#### RF Common Mode

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in CS testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant CS standards. The immunity test signal from the CS system meet the required specifications in IEC 61000-4-6 through the calibration for unmodulated signal and monitoring for the test level with the uncertainty evaluation report for the injected modulated signal level through CDN and EM Clamp/Direct Injection as being 3.72 dB and 2.78 dB.

#### Voltage Dips and Interruption

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in DIP testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant DIP standards. The immunity test signal from the DIP system meet the required specifications in IEC 61000-4-11 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.63% and 2.76%.

#### Transients and Surges

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in Transients and Surges testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant DIP standards. The immunity test signal from the Transients and Surges system meet the required specifications in ISO 7637-2 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.60% and 2.60%.

### **2 GENERAL INFORMATION**

### 2.1 Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Normal Temperature:	15°C -35°C
Relative Humidity	35%-55 %
Air Pressure	101KPa

### 2.2 General Description of EUT

Product Name:		ShotKam A	ction Camera					
Model/Type referenc	e:	Shotgun Sh	hotKam					
Power supply:		DC 3.7V fro	om battery					
WIFI 2.4G								
Supported type:		802.11b/80	2.11g/802.11n(H20)/8	02.11n(H40)				
Modulation:		802.11b: D3 802.11g/80	SSS 2.11n(H20)/802.11n(H	40): OFDM				
Operation frequency	1		2.11g/802.11n(H20): 2 0): 2422MHz~2462M		z			
Channel number:	S	802.11b/80 802.11n(H4	2.11g/802.11n(H20): 1 Ю): 9	3 D				
Channel separation:	he	5MHz	5MHz					
Antenna type:	né	Ceramic ar	Ceramic antenna					
Antenna gain:	N	2.2dBi		L Ŭ				
WIFI 5G								
	20MH	z system	40MHz system	80MHz system	160MHz system			
Supported type:	80	2.11a 2.11n 2.11ac	802.11n 802.11ac	802.11ac	N/A			
Operation frequency:	5180MH	z-5240MHz	5190MHz-5230MHz	5210MHz	N/A			
Modulation:	0	FDM	OFDM	OFDM	N/A			
Channel number:		4	2	1	N/A			
Channel separation:	20	MHz	40MHz	80MHz	N/A			
Antenna type:		antenna: 4.5	dBi on 5GHz tion_please refer to the					

Note: For more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

### 2.3 Description of Test Modes

The EUT was tested under typical operating condition. The applicant provides drivers to make it work in general use, and software can obtain data form it to see if it works intended during testing.

Cond	Conducted Emission						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due	
1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	103710	2018/06/02	2019/06/01	
2	LISN	ROHDE & SCHWARZ	ESH2-Z5	860014/010	2018/06/02	2019/06/01	

Radiated Emission						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due
1	ULTRA-BROAD BAND ANTENNA	Sunol Sciences Corp.	JB1 Antenna	A061713	2018/06/02	2019/06/01
2	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	1166.5950.03	2018/06/02	2019/06/01
3	Horn Antenna	Sunol Sciences Corp	DRH-118	A062013	2018/05/19	2019/05/18
4	Pre-Amplifier	Agilent	8447D	2944A10176	2018/05/26	2019/05/25
5	Pre-Amplifier	Agilent	8449B	3008A02306	2018/05/19	2019/05/18
-		() N/2	// <del>//////</del> //		D	

Electrostatic Discharge						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due
1	ESD Simulator	EM TEST	dito	SA31300000 1	2018/05/22	2019/05/21

RF Fi	RF Field Strength Susceptibility					
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due
1	SIGNAL GENERATOR	IFR	es 2032	203002/100	2018/06/02	2019/06/01
2	AMPLIFIER	AR	150W1000	301584	2018/06/02	2019/06/01
3	DUAL DIRECTIONAL COUPLER	AR	DC6080	301508	2018/06/02	2019/06/01
4	POWER HEAD	AR	PH2000	301193	2018/06/02	2019/06/01
5	POWER METER	AR	PM2002	302799	2018/06/02	2019/06/01

The calibration interval is 1 year.

### **3 TEST CONDITIONS AND RESULTS**

### 3.1 EMC EMISSION TEST

#### 3.1.1 Conducted Emission (AC Mains)

#### <u>LIMIT</u>

FREQUENCY (MHz)	Class A	(dBuV)	Class B (dBuV)		
FREQUENCT (MITZ)	Quasi-peak	Average	Quasi-peak	Average	
0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46 *	
0.50 -5.0	73.00	60.00	56.00	46.00	
5.0 -30.0	73.00	60.00	60.00	50.00	

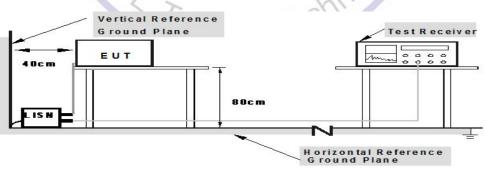
Note: (1)The tighter limit applies at the band edges.

(2)The limit of " \* " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

#### TEST PROCEDURE

- a) The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b) Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c) I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d) LISN at least 40 cm from nearest part of EUT chassis.
- e) For the actual test configuration, please refer to the related Item -EUT Test Photos.

#### TEST SETUP

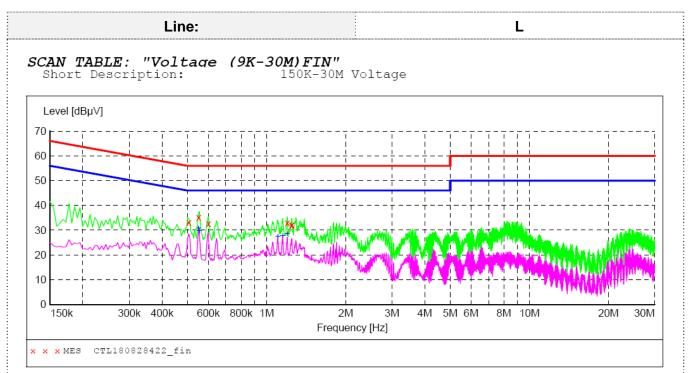


Note: 1.Support units were connected to second LISN. 2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

#### **TEST RESULTS**

#### -----Passed-----

#### Please refer to the below test data:

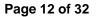


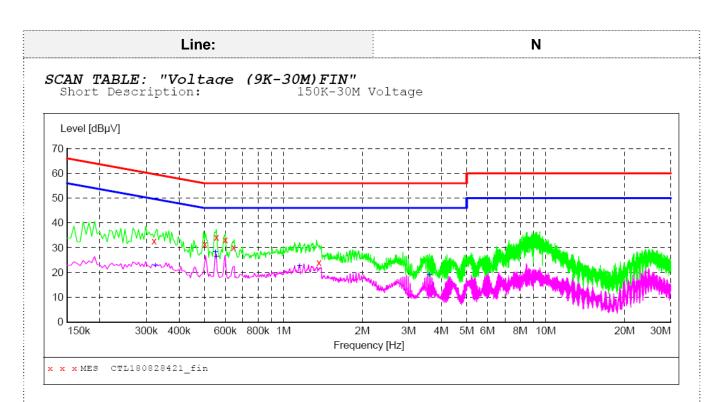
#### MEASUREMENT RESULT: "CTL180828422\_fin"

2018-8-2	28 05:5	5??						
Frequ	lency	Level	Transd	Limit	Margin	Detector	Line	ΡE
	MHz	dBµV	dB	dBµV	dB			
0.50	)5500	33.10	10.2	56	22.9	QP	L1	GND
0.55	50500	35.20	10.2	56	20.8	QP	L1	GND
0.60	0000	32.80	10.2	56	23.2	QP	L1	GND
1.19	98500	33.00	10.3	56	23.0	QP	L1	GND
1.24	13500	31.90	10.3	56	24.1	QP	L1	GND
1.24	8000	32.10	10.3	56	23.9	QP	L1	GND

MEASUREMENT RESULT: "CTL180828422 fin2"

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.550500	30.70	10.2	46	15.3	AV	L1	GND
0.555000	29.60	10.2	46	16.4	AV	L1	GND
1.104000	27.40	10.3	46	18.6	AV	L1	GND
1.153500	27.60	10.3	46	18.4	AV	L1	GND
1.198500	28.30	10.3	46	17.7	AV	L1	GND
 1.198500	28.30	10.3	46	17.7	AV	L1	GND





#### MEASUREMENT RESULT: "CTL180828421 fin"

2018-8-28 05:51?? Frequency Level Transd Limit Margin Detector Line PE dBµV dB MHz dB dBµV 0.321000 32.60 10.2 60 27.1 QP Ν GND 0.501000 31.50 10.2 56 24.5 GND QP Ν 0.555000 34.20 10.2 56 21.8 QP Ν GND 10.2 22.8 QP 0.600000 33.20 56 Ν GND 56 25.8 QP 0.645000 30.20 10.2 Ν GND 1.365000 24.10 10.3 56 31.9 QP Ν GND

#### MEASUREMENT RESULT: "CTL180828421 fin2"

	-28 05:5 equency MHz		Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
	325500	22.80	10.2	50	26.8	AV	N	GND
0.	550500	28.00	10.2	46	18.0	AV	N	GND
Ο.	555000	26.40	10.2	46	19.6	AV	N	GND
1.	153500	22.50	10.3	46	23.5	AV	N	GND
3.	597000	19.00	10.4	46	27.0	AV	N	GND

#### 3.1.2 Radiated Emission

#### <u>LIMIT</u>

#### LIMITS OF RADIATED EMISSION MEASUREMENT (Below 1000MHz)

	Class B(at 10m)	Class B (at 3m)
FREQUENCY (MHz)	dBuV/m	dBuV/m
30 – 230	30	40
230 – 1000	37	47

#### LIMITS OF RADIATED EMISSION MEASUREMENT(Above 1000MHz)

	Class A (at 1	0m) dBuV/m	Class B (at 3m) dBuV/m		
FREQUENCY (MHz)	Peak	Avg	Peak	Avg	
1000-3000	76	56	70	50	
3000-6000	80	60	74	54	

Notes: (1)The limit for radiated test was performed according to as following:

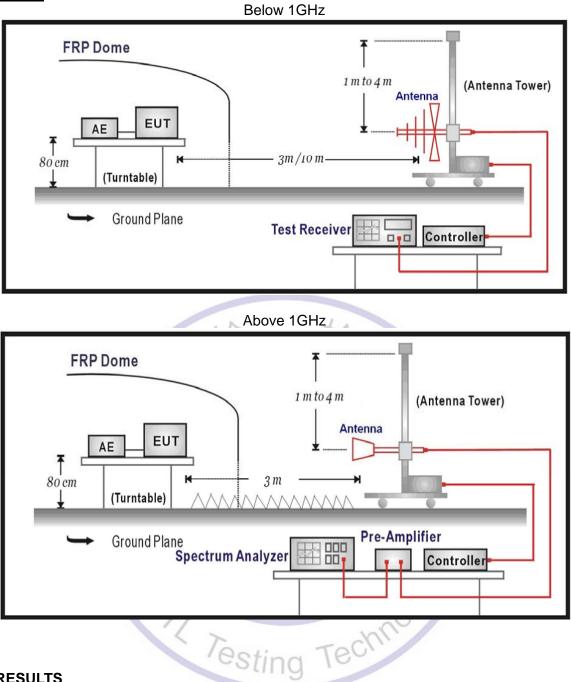
ETSI EN 301 489-1/EN 55032

(2)The tighter limit applies at the band edges.

#### TEST PROCEDURE

- a) The EUT was placed on the top of a rotating table 3 meters away from the receiver antenna and 0.8 meters above the ground at a 9X9X6 anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- b) The height of the equipment shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- c) The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak/Average detector mode re-measured.
- d) If the Peak Mode measured value compliance with and lower than Quasi Peak/Average Mode Limit, the EUT shall be deemed to meet QP/AV Limits and then no additional QP/AV Mode measurement performed.
- e) For the actual test configuration, please refer to the related Item –EUT Test Photos.

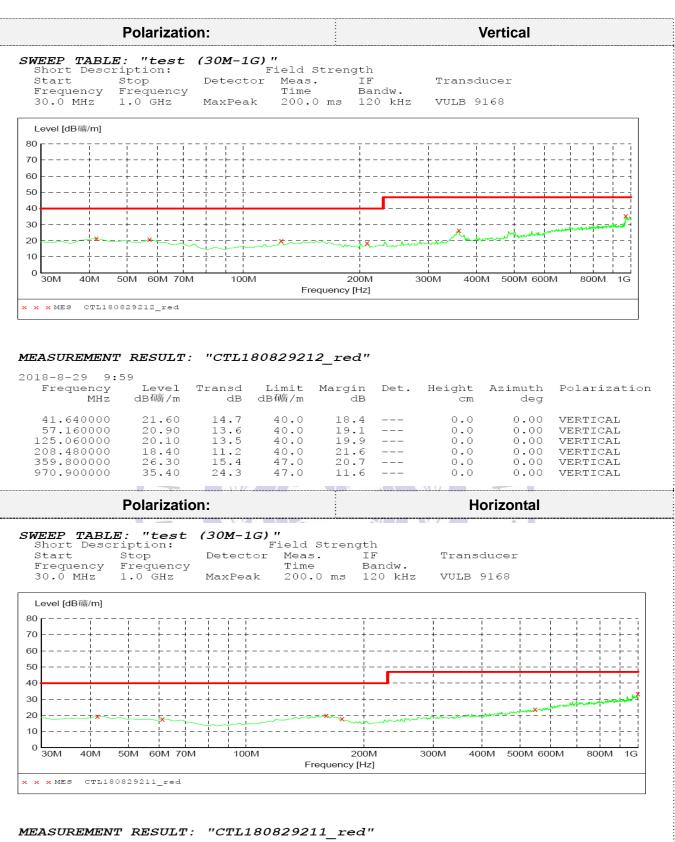
#### TEST SETUP



-Passed-----

#### TEST RESULTS

Please refer to the below test data:



2018-8-29 9:57 Det. Height Azimuth Polarization Level Transd Limit Margin Frequency dB礦/m dB礦/m deg MHz dB dB сm 40.0 41.640000 19.40 14.7 20.6 \_\_\_ 0.0 0.00 HORIZONTAL 17.70 13.2 15.2 22.3 \_\_\_ 61.040000 40.0 0.0 0.00 HORTZONTAL 20.1 159.980000 19.90 40.0 \_\_\_ 0.00 HORIZONTAL 0.0 175.500000 17.90 13.4 40.0 22.1 \_\_\_ 0.0 0.00 HORIZONTAL 546.040000 23.70 19.0 47.0 23.3 \_\_\_\_ 0.0 0.00 HORIZONTAL 1000.000000 33.30 24.3 47.0 13.7 \_ \_ \_ 0.0 0.00 HORIZONTAL

Note :Above 1-6G had been tested and found on emission except floor noise

### 3.2 EMC IMMUNITY TEST

#### 3.2.1 Immunity Performance criteria

#### A. General Requirements (ETSI EN 301489-1):

The performance criteria criteria are used to take a decision on whether radio equipment passes or fails immunity tests.

For the purpose of the present document four categories of performance criteria apply:

- Performance criteria for continuous phenomena applied to transmitters and receivers
- Performance criteria for transient phenomena applied to transmitters and receivers
- Performance criteria for equipment which does not provide a continuous communication link
- Performance criteria for ancillary equipment tested on a stand alone basis

(1) Performance criteria for continuous phenomena applied to transmitters and receivers If no further details are given in the relevant part of ETSI EN 301 489 series [i.13] dealing with the particular type of radio equipment, the following general performance criteria for continuous phenomena shall apply.

During and after the test, the equipment shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer when the equipment is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the test the EUT shall not unintentionally transmit or change its actual operating state and stored data.

If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.

(2) Performance criteria for transient phenomena applied to transmitters and receivers If no further details are given in the relevant part of ETSI EN 301 489 series [i.13] dealing with the particular type of radio equipment, the following general performance criteria for transient phenomena shall apply.

For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:

- f) For products with only one symmetrical port intended for connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A SW reboot is not allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.
- g) For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. A SW reboot is not allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

For all other ports the following applies:

- h) After the test, the equipment shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer, when the equipment is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.
- i) During the EMC exposure to an electromagnetic phenomenon, a degradation of performance is, however, allowed. No change of the actual mode of operation (e.g. unintended transmission) or

stored data is allowed.

j) If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.

# (3) Performance criteria for equipment which does not provide a continuous communication link

For radio equipment which does not provide a continuous communication link, the performance criteria described in clauses 6.1 and 6.2 are not appropriate, in these cases the manufacturer shall declare, for inclusion in the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests. The performance specification shall be included in the product description and documentation. The related specifications set out in clause 5.3 have also to be taken into account.

The performance criteria specified by the manufacturer shall give the same degree of immunity protection as called for in clauses 6.1 and 6.2.

#### (4) Performance criteria for ancillary equipment tested on a stand alone basis

If ancillary equipment is intended to be tested on a stand alone basis, the performance criteria described in clauses 6.1 and 6.2 are not appropriate, in these cases the manufacturer shall declare, for inclusion in the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests. The performance specification shall be included in the product description and documentation. The related specifications set out in clause 5.3 have also to be taken into account.

The performance criteria specified by the manufacturer shall give the same degree of immunity protection as called for in clauses 6.1 and 6.2.

#### B. EN301489-17

#### General performance criteria

- Performance criteria A for immunity tests with phenomena of a continuous nature;
- Performance criteria B for immunity tests with phenomena of a transient nature;
- Performance criteria C for immunity tests with power interruptions exceeding a certain time.

The equipment shall meet the minimum performance criteria as specified in the following.

Criteria	During test	After test
A	Shall operate as intended. (see note 1). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended. Shall be no degradation of performance (see note 3) Shall be no loss of function. Shall be no loss of stored data or user programmable functions.
В	May show loss of function (one or more). May show degradation of performance (see note 2). Shall be no unintentional transmissions.	Functions shall be self-recoverable. Shall operate as intended after recovering. Shall be no degradation of performance (see note 3) Shall be no loss of stored data or user programmable functions.
С	May be loss of function (one or more).	Functions shall be recoverable by the operator. Shall operate as intended after recovering. Shall be no degradation of performance (see note 3).

NOTE 1:

Operate as intended during the test allows a level of degradation not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum

performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

#### NOTE 2:

Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended. NOTE 3:

No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

#### Performance criteria for Continuous phenomena applied to Transmitters (CT)

The performance criteria A shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or Not ACKnowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### Performance criteria for Transient phenomena applied to Transmitters (TT)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### Performance criteria for Continuous phenomena applied to Receivers (CR)

The performance criteria A shall apply.

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### Performance criteria for Transient phenomena applied to Receivers (TR)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply.

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test.

In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### 3.2.2 Electrostatic Discharge

#### **TEST SPECIFICATION**

Basic Standard:	IEC/EN 61000-4-2	
Discharge Impedance:	330 ohm / 150 pF	
Required Performance	В	
Discharge Voltage:	Air Discharge:2kV/4kV/8kV (Direct)	
	Contact Discharge:2kV/4kV (Direct/Indirect)	
Polarity:	Positive & Negative	
Number of Discharge:	Air Discharge: min. 20 times at each test point	
	Contact Discharge: min. 200 times in total	
Discharge Period:	1 second minimum	

#### **TEST PROCEDURE**

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a) Contact discharge was applied to conductive surfaces and coupling planes of the EUT. During the test, it was performed with single discharges. For the single discharge time between successive single discharges was at least 1 second. The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges.

If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

Vertical Coupling Plane (VCP):

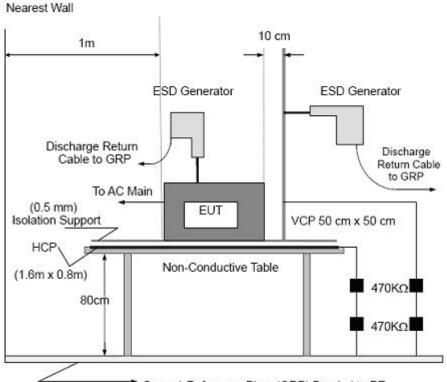
The coupling plane, of dimensions 0.5m x 0.5m, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane. The four faces of the EUT will be performed with electrostatic discharge. SUIL

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane. The four faces of the EUT will be performed with electrostatic discharge.

- b) Air discharges at insulation surfaces of the EUT. It was at least ten single discharges with positive and negative at the same selected point.
- c) For the actual test configuration, please refer to the related Item –EUT Test Photos.

#### TEST SETUP



Ground Reference Plane(GRP) Bonded to PE

#### Note:

#### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

#### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

### TEST RESULTS

-----Passed-----

Please refer to the below test data:

Direct discharge	•			
Type of discharge	Discharge voltage (KV)	Observations Performance	Criteria Level	Result
Contact	±2	В	В	
discharge	±4	В	В	
	±2	A	В	Pass
Air discharge	±4	В	В	
	±8	В	В	
Indirect discharg	je			
Type of discharge	Discharge voltage (KV)	Observations Performance	Criteria Level	Result
	±2	A	В	
HCP (6 sides)	±4/	A	В	Deee
VCP (4 sides)	±2	A	B	Pass
	<u>S</u> ±4	A	В	

Note1: The EUT loss communication link a while and it can self-recoverable after test.

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#### 3.2.3 RF Electromagnetic Field

#### **TEST SPECIFICATION**

Basic Standard:	IEC/EN 61000-4-3
Required Performance	A
Frequency Range:	80 MHz - 6000 MHz
Field Strength: 3 V/m	
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Dwell Time:	at least 3 seconds

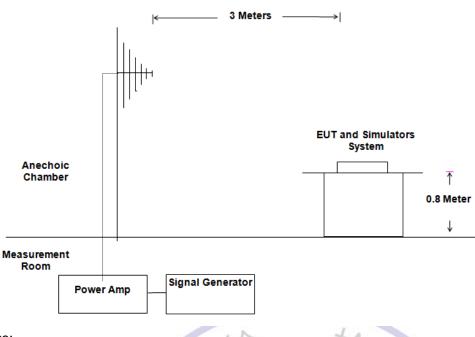
#### TEST PROCEDURE

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber. The testing distance from antenna to the EUT was 3 meters. The other condition as following manner:

- a) The field strength level was 3V/m.
- b) The frequency range is swept from 80 MHz to 6000 MHz with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c) Sweep Frequency 900 MHz, with the Duty Cycle:1/8 and Modulation: Pulse 217 Hz(if applicable)
- d) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

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f) For the actual test configuration, please refer to the related Item -EUT Test Photos.



Note:

#### TABLE-TOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

#### FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

Passed

#### TEST RESULTS

Frequency **RF** Field R.F. Observations Perform. Range Azimuth Result Position Performance Criteria Field Strength (MHz) Front 3 V/m (rms) Rear PASS 80~6000 A A H/V AM Modulated Left 1000Hz, 80% Right

Please refer to the below test data:

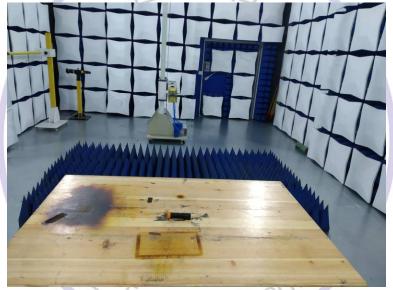
Note1: The EUT can maintain communication link and not operate unintentionally during the test also can operate without any loss of user control functions after test.

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### **4 TEST SETUP PHOTOS**

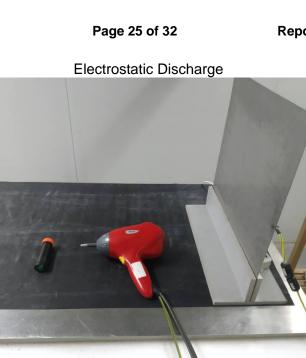


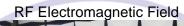
Radiated Emission 1GHz-6GHz



Conducted disturbance





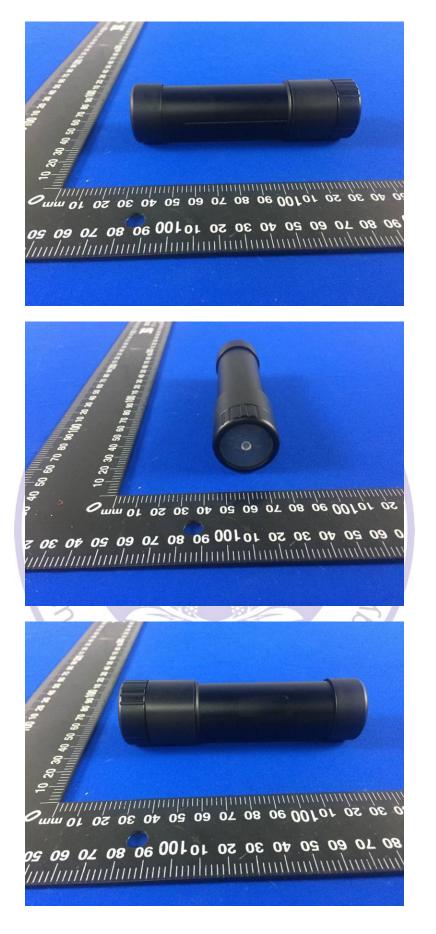


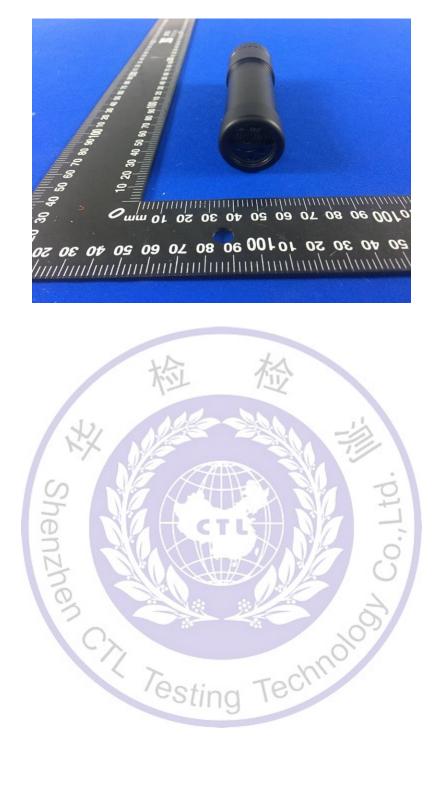


### **5 PHOTOS OF THE EUT**

External Photos of EUT



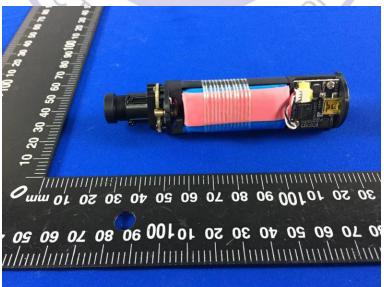


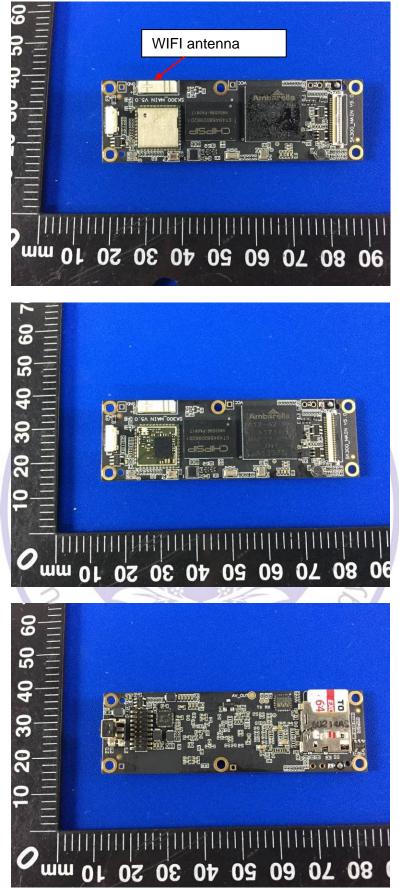


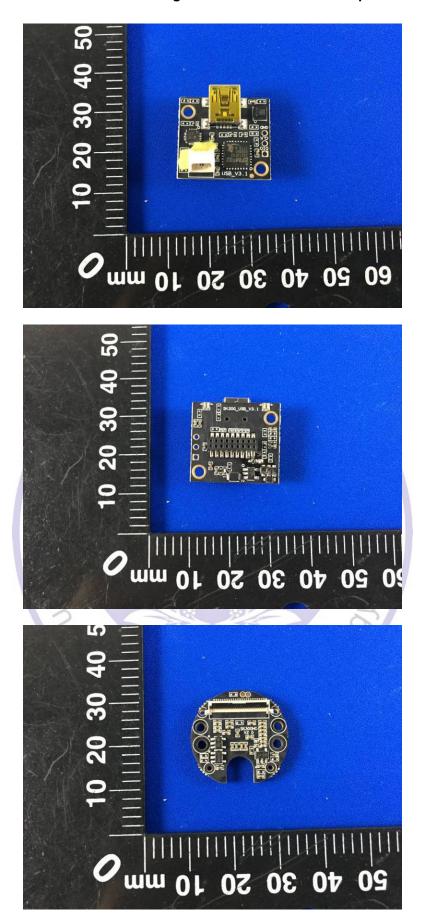
#### Internal Photos of EUT











V1.0

